

<b>Notice of References Cited</b>	Application/Control No. 10/524,481		Applicant(s)/Patent Under Reexamination AKEMAKOU, ANTOINE DOKOU	
	Examiner NAISHADH N. DESAI		Art Unit 2834	Page 1 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,011,479 A	03-1977	Volkrodt, Wolfgang	310/186
*	B	US-4,745,312 A	05-1988	Nagasaka, Nagahiko	310/49R
*	C	US-5,663,605 A	09-1997	Evans et al.	310/181
*	D	US-5,693,995 A	12-1997	Syverson, Charles D.	310/114
*	E	US-5,747,909 A	05-1998	Syverson et al.	310/156.56
*	F	US-5,753,989 A	05-1998	Syverson et al.	310/114
*	G	US-6,072,257 A	06-2000	Akemakou, Dokou Antoine	310/191
*	H	US-6,147,429 A	11-2000	Akemakou et al.	310/181
*	I	US-6,236,134 B1	05-2001	Syverson, Charles D.	310/181
*	J	US-6,271,613 B1	08-2001	Akemakou et al.	310/181
*	K	US-6,509,664 B2	01-2003	Shah et al.	310/181
*	L	US-6,784,586 B2	08-2004	Akemakou, Antoine Dokou	310/194
*	M	US-6,847,143 B1	01-2005	Akemakou, Dokou Antoine	310/156.43

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 741444 A1	11-1996	European Patent	EVANS et al.	H02K 21/04
	O	WO 9967871 A1	12-1999	World Intellect	AKEMAKOU et al.	H02K 01/22
	P	FR 2787645 A1	06-2000	France	AKEMAKOU, DOKOU ANTOINE	H02K 21/00
	Q	WO 38301 A1	06-2000	World Intellect	AKEMAKOU, DOKOU ANTOINE	H02K 19/10
	R	WO 38298 A1	06-2000	World Intellect	AKEMAKOU, DOKOU ANTOINE	H02K 01/27
	S	FR 2787646 A1	06-2000	France	AKEMAKOU, DOKOU ANTOINE	H02K 21/00
	T	WO 57534 A1	09-2000	World Intellect	AKEMAKOU, DOKOU ANTOINE	H02K 01/02

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/524,481		Applicant(s)/Patent Under Reexamination AKEMAKOU, ANTOINE DOKOU	
	Examiner NAISHADH N. DESAI		Art Unit 2834	Page 2 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0248229 A1	11-2005	Even et al.	310/180
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	FR 2856532 A1	12-2004	France	LEROY et al.	H02K 01/27
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.